

# INTERNATIONAL STANDARD

## NORME INTERNATIONALE

**Assessment methods of the human exposure to electric and magnetic fields from wireless power transfer systems – Models, instrumentation, measurement and computational methods and procedures (frequency range of 3 kHz to 30 MHz)**

**Méthodes d'évaluation de l'exposition humaine aux champs électriques et magnétiques produits par les systèmes de transfert de puissance sans fil – Modèles, instrumentation, méthodes et procédures de mesure et de calcul (Plage de fréquences comprise entre 3 kHz et 30 MHz)**





**THIS PUBLICATION IS COPYRIGHT PROTECTED**  
**Copyright © 2025 IEC, Geneva, Switzerland**  
**Copyright © 2025 IEEE**

All rights reserved. Unless otherwise specified, no part of this publication may be reproduced or utilized in any form or by any means, electronic or mechanical, including photocopying and microfilm, without permission in writing being secured. Requests for permission to reproduce should be addressed to either IEC at the address below or IEC's member National Committee in the country of the requester or from IEEE.

IEC Secretariat  
3, rue de Varembe  
CH-1211 Geneva 20  
Switzerland  
Tel.: +41 22 919 02 11  
[info@iec.ch](mailto:info@iec.ch)  
[www.iec.ch](http://www.iec.ch)

Institute of Electrical and Electronics Engineers, Inc.  
3 Park Avenue  
New York, NY 10016-5997  
United States of America  
[stds.ipr@ieee.org](mailto:stds.ipr@ieee.org)  
[www.ieee.org](http://www.ieee.org)

#### About the IEC

The International Electrotechnical Commission (IEC) is the leading global organization that prepares and publishes International Standards for all electrical, electronic and related technologies.

#### About IEC publications

The technical content of IEC publications is kept under constant review by the IEC. Please make sure that you have the latest edition, a corrigendum or an amendment might have been published.

#### IEC publications search - [webstore.iec.ch/advsearchform](http://webstore.iec.ch/advsearchform)

The advanced search enables to find IEC publications by a variety of criteria (reference number, text, technical committee, ...). It also gives information on projects, replaced and withdrawn publications.

#### IEC Just Published - [webstore.iec.ch/justpublished](http://webstore.iec.ch/justpublished)

Stay up to date on all new IEC publications. Just Published details all new publications released. Available online and once a month by email.

#### IEC Customer Service Centre - [webstore.iec.ch/csc](http://webstore.iec.ch/csc)

If you wish to give us your feedback on this publication or need further assistance, please contact the Customer Service Centre: [sales@iec.ch](mailto:sales@iec.ch).

#### IEC Products & Services Portal - [products.iec.ch](http://products.iec.ch)

Discover our powerful search engine and read freely all the publications previews, graphical symbols and the glossary. With a subscription you will always have access to up to date content tailored to your needs.

#### Electropedia - [www.electropedia.org](http://www.electropedia.org)

The world's leading online dictionary on electrotechnology, containing more than 22 500 terminological entries in English and French, with equivalent terms in 25 additional languages. Also known as the International Electrotechnical Vocabulary (IEV) online.

<https://standards.iec.ch/catalog/standards/iec/63184-2025>

<https://standards.iec.ch/catalog/standards/iec/63184-2025>

#### A propos de l'IEC

La Commission Electrotechnique Internationale (IEC) est la première organisation mondiale qui élabore et publie des Normes internationales pour tout ce qui a trait à l'électricité, à l'électronique et aux technologies apparentées.

#### A propos des publications IEC

Le contenu technique des publications IEC est constamment revu. Veuillez vous assurer que vous possédez l'édition la plus récente, un corrigendum ou amendement peut avoir été publié.

#### Recherche de publications IEC -

[webstore.iec.ch/advsearchform](http://webstore.iec.ch/advsearchform)

La recherche avancée permet de trouver des publications IEC en utilisant différents critères (numéro de référence, texte, comité d'études, ...). Elle donne aussi des informations sur les projets et les publications remplacées ou retirées.

#### IEC Just Published - [webstore.iec.ch/justpublished](http://webstore.iec.ch/justpublished)

Restez informé sur les nouvelles publications IEC. Just Published détaille les nouvelles publications parues. Disponible en ligne et une fois par mois par email.

#### Service Clients - [webstore.iec.ch/csc](http://webstore.iec.ch/csc)

Si vous désirez nous donner des commentaires sur cette publication ou si vous avez des questions contactez-nous: [sales@iec.ch](mailto:sales@iec.ch).

#### IEC Products & Services Portal - [products.iec.ch](http://products.iec.ch)

Découvrez notre puissant moteur de recherche et consultez gratuitement tous les aperçus des publications, symboles graphiques et le glossaire. Avec un abonnement, vous aurez toujours accès à un contenu à jour adapté à vos besoins.

#### Electropedia - [www.electropedia.org](http://www.electropedia.org)

Le premier dictionnaire d'électrotechnologie en ligne au monde, avec plus de 22 500 articles terminologiques en anglais et en français, ainsi que les termes équivalents dans 25 langues additionnelles. Egalement appelé Vocabulaire Electrotechnique International (IEV) en ligne.



IEEE

IEC/IEEE 63184

Edition 1.0 2025-02

# INTERNATIONAL STANDARD

## NORME INTERNATIONALE

**Assessment methods of the human exposure to electric and magnetic fields from wireless power transfer systems – Models, instrumentation, measurement and computational methods and procedures (frequency range of 3 kHz to 30 MHz)**

Document Preview

**Méthodes d'évaluation de l'exposition humaine aux champs électriques et magnétiques produits par les systèmes de transfert de puissance sans fil – Modèles, instrumentation, méthodes et procédures de mesure et de calcul (Plage de fréquences comprise entre 3 kHz et 30 MHz)**

INTERNATIONAL  
ELECTROTECHNICAL  
COMMISSION

COMMISSION  
ELECTROTECHNIQUE  
INTERNATIONALE

ICS 17.220.20; 17.240

ISBN 978-2-8327-0139-3

**Warning! Make sure that you obtained this publication from an authorized distributor.  
Attention! Veuillez vous assurer que vous avez obtenu cette publication via un distributeur agréé.**

## CONTENTS

FOREWORD.....	10
INTRODUCTION.....	12
1 Scope.....	13
2 Normative references.....	13
3 Terms and definitions .....	14
4 Symbols and abbreviated terms .....	19
4.1 Physical quantities .....	19
4.2 Constants .....	19
4.3 Abbreviated terms .....	19
5 Assessment procedures.....	20
5.1 General.....	20
5.2 Compliance assessment considering direct effects.....	21
5.2.1 General .....	21
5.2.2 Tier 1: Evaluation based on coil current.....	22
5.2.3 Tier 2: Evaluation of incident fields against reference levels.....	23
5.2.4 Tier 3: Evaluation of incident magnetic fields using coupling factor.....	23
5.2.5 Tier 4: Evaluation of internal E-field, current density, or SAR against basic restrictions .....	29
5.3 Exposure assessment of contact currents .....	29
6 Measurement methods.....	31
6.1 Incident fields.....	31
6.1.1 General .....	31
6.1.2 Equipment .....	32
6.2 SAR and $pE_{ind}$ .....	34
6.3 Contact currents.....	36
6.3.1 General .....	36
6.3.2 Equipment .....	36
6.3.3 Measurements .....	37
7 Computational assessment methods .....	38
7.1 General.....	38
7.2 Quasi-static approximation .....	39
7.3 Computational assessment against the basic restrictions .....	40
7.3.1 General .....	40
7.3.2 Peak spatial-average SAR.....	41
7.3.3 Whole-body average SAR .....	41
7.3.4 Averaged current density on a surface.....	41
7.3.5 Peak spatial average internal E-field in a cubical volume .....	41
7.3.6 Peak spatial average internal E-field along a line .....	41
7.3.7 Maximum local internal E-field.....	41
8 Combination of measurement and computational methods for inductive WPT systems.....	42
8.1 General.....	42
8.2 Measurement of magnetic field .....	42
8.3 Computational analyses of induced quantities.....	42
8.4 Computational assessment against the basic restrictions .....	43
9 Uncertainty assessments .....	43

9.1	General.....	43
9.2	Measurement methods .....	43
9.2.1	Measurement uncertainty budget.....	43
9.2.2	Amplitude calibration uncertainty .....	44
9.2.3	Probe anisotropy .....	45
9.2.4	Probe dynamic range linearity .....	45
9.2.5	Probe frequency domain response.....	45
9.2.6	Modulation response .....	45
9.2.7	Spatial averaging (maximum gradient).....	45
9.2.8	Gradient assessment uncertainty.....	45
9.2.9	Parasitic E-field and H-field sensitivity .....	45
9.2.10	Detection limit .....	45
9.2.11	Readout electronics .....	46
9.2.12	Response time .....	46
9.2.13	Probe positioning .....	46
9.2.14	Signal postprocessing .....	46
9.2.15	Nominal position .....	46
9.2.16	Repeatability.....	46
9.2.17	DUT.....	46
9.3	Computational methods.....	46
9.3.1	Computational uncertainty budget .....	46
9.3.2	Grid resolution .....	48
9.3.3	Tissue parameters .....	48
9.3.4	Exposure position .....	48
9.3.5	Convergence .....	48
9.3.6	Power budget.....	49
9.3.7	Boundary conditions.....	49
9.3.8	Quasi-static approximation .....	49
9.3.9	Model parts and geometry .....	49
9.3.10	Dielectric parameters .....	49
9.3.11	Ferrite parameters .....	50
9.3.12	Positioning of transmit and receive coils .....	50
9.3.13	Coupling of transmit and receive coils .....	50
9.3.14	Exposure sources other than the coils .....	50
9.3.15	Loading of the coil.....	50
9.4	Assessment of combining measurement and computational methods.....	50
10	Reporting .....	51
10.1	General.....	51
10.2	Items to be recorded in exposure compliance assessment reports.....	51
10.3	Additional items to be included for evaluation measurements .....	52
10.4	Additional items to be included for numerical and combined numerical and measurement evaluations.....	53
Annex A	(normative) Exposure evaluations using approximations .....	54
A.1	Limit on current for a WPT coil .....	54
A.2	Induced field quantities for comparison with basic restrictions .....	55
A.3	Enhancement or coverage factor .....	57
Annex B	(normative) Calibration methods.....	58
B.1	General.....	58
B.2	E-field and H-field calibration.....	58

B.2.1	Standard field generation methods .....	58
B.2.2	Characteristics to be measured .....	58
B.2.3	Frequency domain calibration.....	60
B.2.4	E-field calibration .....	63
B.3	Gradient response verification .....	67
B.3.1	General .....	67
B.3.2	H-field gradient verification: Main steps .....	67
B.3.3	Uncertainty for H-field gradient verification .....	67
B.4	Dosimetric probe calibration .....	68
B.4.1	General .....	68
B.4.2	Calibration with short dipole antennas via transmit antenna factor .....	69
B.4.3	Uncertainty .....	72
Annex C (normative)	Verification and validation methods for measurements .....	73
C.1	General.....	73
C.2	Objective .....	73
C.3	Measurement setup and procedure for system verification and system validation .....	73
C.3.1	General .....	73
C.3.2	Measurement system verification: test procedure.....	74
C.3.3	Measurement system validation: test procedure.....	75
Annex D (informative)	Case study on the dependency of SAR on phantom properties and size.....	76
D.1	Phantom properties.....	76
D.2	Phantom size .....	79
Annex E (informative)	Extrapolation methods of SAR measurement .....	82
E.1	General.....	82
E.2	Measurement and interpolation of electric field inside a phantom .....	82
E.2.1	General .....	82
E.2.2	Extrapolation functions.....	82
E.2.3	Three steps for determination of spatial-peak SAR.....	83
E.2.4	Validation of measurement methods using extrapolation .....	83
E.2.5	Uncertainty .....	86
Annex F (informative)	Computational methods.....	88
F.1	General.....	88
F.2	Quasi-static finite element method.....	88
F.3	Scalar potential finite difference method .....	89
F.4	Impedance method.....	90
F.5	Finite-difference time-domain method .....	91
F.6	Hybrid technique of MoM and FDTD method .....	91
F.7	Hybrid technique of FEM and SPFD method .....	93
Annex G (informative)	Averaging algorithms .....	94
G.1	Current density averaging over an area .....	94
G.1.1	General .....	94
G.1.2	Calculation of the current density in a Cartesian voxel .....	94
G.1.3	Calculation of the current density in a tetrahedron .....	95
G.1.4	Calculation of $J_{av}$ .....	95
G.2	Internal E-field .....	96
G.2.1	General .....	96

G.2.2	E-field averaging in a cubical volume.....	96
G.2.3	E-field averaging along an averaging distance .....	97
G.2.4	Maximum local E-field .....	99
Annex H (normative)	Code verification and model validations .....	100
H.1	Code verification .....	100
H.1.1	General .....	100
H.1.2	Quasi-static codes .....	100
H.1.3	Quasi-static codes for the calculation of the incident magnetic field.....	101
H.1.4	Averaging algorithms .....	103
H.2	Model validation .....	104
H.2.1	General .....	104
H.2.2	Recommendations for the development of the computational model .....	105
H.2.3	Determining the validity of the field source.....	105
Annex I (informative)	Use cases of magnetic field exposure assessment.....	107
I.1	EV WPT – electric passenger car .....	107
I.1.1	General .....	107
I.1.2	Determination of user position .....	107
I.1.3	Assessment procedures considering direct effects for WPT system for EV ..	108
I.1.4	Assessment procedures for contact currents of WPT systems for EV.....	114
I.2	Heavy duty vehicle EMF measurement procedure .....	119
I.2.1	General .....	119
I.2.2	Step 1.....	119
I.2.3	Step 2.....	121
I.2.4	Step 3.....	121
I.3	Remotely piloted aircraft.....	122
I.3.1	General .....	122
I.3.2	Assessment procedures of WPT system for RPA .....	122
Annex J (informative)	Examples of magnetic field exposure assessment .....	126
J.1	General.....	126
J.2	Assessment procedure of heavy-duty WPT EV system.....	126
J.2.1	Outline of assessment procedure .....	126
J.2.2	Test condition .....	126
J.2.3	Test result 1.....	127
J.2.4	Test result 2.....	127
J.2.5	Test result 3.....	127
J.3	Remotely piloted aircraft.....	127
J.3.1	General .....	127
J.3.2	Description of WPT system for RPA.....	128
J.3.3	Measurement of magnetic field around the WPT system for RPA.....	128
J.3.4	Modelling for the WPT system for RPA .....	129
J.3.5	Evaluation of incident field against basic restrictions.....	129
J.3.6	Evaluation of current density, internal electric field, and SAR against basic restrictions .....	132
J.4	Combined method of measurement and computational analysis .....	132
J.4.1	General .....	132
J.4.2	Measurement of magnetic field.....	132
J.4.3	Computational analyses of induced quantities.....	133
J.4.4	Example of exposure assessment for WPT systems using combined method .....	133



J.5 SAR measurement for WPT system .....	137
Annex K (informative) Proximity detection sensor considerations for exposure assessment .....	139
K.1 General.....	139
K.2 Phantom specification .....	139
K.2.1 Phantom for the stationary living object detection .....	139
K.2.2 Phantom for the proximity living object detection.....	139
K.3 Procedures for determining proximity detection sensor triggering distance.....	140
K.4 Testing areas .....	140
K.5 Procedures for determining stationary living objects .....	141
Bibliography .....	143
Figure 1 – Flowchart for the assessment procedure .....	20
Figure 2 – Flowchart for the assessment procedure considering direct effects .....	21
Figure 3 – The gradient $G_n$ is determined at the surface and normal to the surface, i.e. in the direction of the axis shown .....	26
Figure 4 – Coupling factors $k$ of Formula (7) through Formula (11) as a function of the normalized magnetic field gradient [13] .....	29
Figure 5 – Two exposure situations for ungrounded and grounded metal objects .....	30
Figure 6 – Flowchart for assessment procedures for contact currents.....	31
Figure 7 – Human body equivalent circuit proposed in IEC 60990 [30] .....	37
Figure 8 – Impedance frequency characteristics of adult male and equivalent circuits proposed in IEC 60990 [30] and evaluated values [31], [32], [33], [34] .....	37
Figure 9 – Example of contact current measurement equipment.....	37
Figure A.1 – Comparison of the H-field with number of turns $n$ at 1 cm from a circular coil calculated with Biot-Savart and with the approximation of Formula (A.1).....	55
Figure B.1 – H-field and E-field generation setup for probe calibration .....	60
Figure B.2 – H-field generation setup for dynamic range calibration .....	62
Figure B.3 – E-field generation setup for frequency response calibration.....	64
Figure B.4 – E-field generation setup for dynamic range calibration .....	65
Figure B.5 – Illustration of the transmit antenna factor evaluation setup [51] .....	71
Figure B.6 – Illustration of the sensitivity coefficients evaluation setup [51] .....	71
Figure C.1 – Recommended test setups for measurement system verification and validation.....	74
Figure D.1 – Simulation model of large WPT system operating close to a) elliptical phantom and b) human body model.....	77
Figure D.2 – Different exposure conditions for human body model .....	77
Figure D.3 – Calculated SAR for circular coils with a 50 cm diameter operating at 6 cm from the elliptical phantom and heterogeneous human model .....	78
Figure D.4 – Simulation model of small WPT system operating close to a) elliptical phantom and b) human body model.....	78
Figure D.5 – Calculated SAR for the small square coils with dimensions 10 cm × 10 cm operating at 2 cm from the elliptical phantom and heterogeneous human model .....	79
Figure D.6 – Layout of large WPT system for exposure condition of a) case A and b) case C with respect to the elliptical phantom surface .....	80



Figure D.7 – Calculated 10 g-averaged SAR versus the smaller axis of elliptical phantom $v$ normalized by coil outer diameter $D$ for a) case A ( $f_{\text{high}} = 7,54$ MHz) and b) case C ( $f_{\text{low}} = 6,14$ MHz, $f_{\text{high}} = 7,18$ MHz) .....	80
Figure D.8 – Layout of small WPT system for exposure conditions of case C with respect to a) elliptical phantom and b) rectangular phantom.....	81
Figure D.9 – Calculated 10 g-averaged SAR versus the smaller axis $v$ or width $W$ normalized by square coil diagonal $K$ for a) elliptical phantom ( $f_{\text{low}} = 6,6$ MHz, $f_{\text{high}} = 7,64$ MHz) and b) rectangular phantom ( $f_{\text{low}} = 6,59$ MHz) .....	81
Figure E.1 – Schematic diagram of measurement system .....	84
Figure E.2 – Measurement system .....	85
Figure E.3 – Measured and simulated electric field distributions in the measurement plane 25 mm away from the phantom boundary with solenoid-type WPT system positioned parallel to the phantom wall.....	85
Figure E.4 – Measured and simulated electric field distributions in the measurement plane 25 mm away from the phantom boundary with flat-spiral-type WPT system positioned parallel to the phantom wall.....	86
Figure E.5 – 10 g averaged SAR obtained by measurement, and extrapolation and MoM-derived 10 g averaged SAR.....	86
Figure G.1 – Field components on voxel edges .....	95
Figure H.1 – Coordinate system and angles .....	102
Figure I.1 – Example for regions of protection, for ground mounted systems (vehicle) [78] .....	107
Figure I.2 – Example for regions of protection, for ground mounted systems (using vehicle mimic plate) .....	108
Figure I.3 – Flowchart for EV and vehicle mimic plate assessment (direct effect).....	109
Figure I.4 – Region 2 measurement positions (WPT) .....	110
Figure I.5 – Region 3 measurement positions .....	111
Figure I.6 – Region 2 measurement positions of vehicle mimic plate (WPT).....	112
Figure I.7 – Region 3 measurement positions of vehicle mimic plate (WPT).....	113
Figure I.8 – Flowchart for EV use and vehicle mimic plate assessment (contact currents).....	114
Figure I.9 – Configuration example of contact current with grounded condition: (1) with vehicle.....	116
Figure I.10 – Configuration example of contact current with grounded condition: (2) with vehicle mimic plate .....	116
Figure I.11 – Configuration example of contact current with ungrounded condition: (1) with vehicle .....	118
Figure I.12 – Configuration example of contact current with ungrounded condition: (2) with vehicle mimic plate .....	119
Figure I.13 – EMF measurement for heavy duty vehicle: top view.....	120
Figure I.14 – EMF measurement for heavy duty vehicle: side view .....	120
Figure I.15 – Measurement points on the inside floor of WPT bus .....	121
Figure I.16 – Measurement position .....	123
Figure J.1 – EMF test of an electric bus (2015 August 7, Sejong City).....	126
Figure J.2 – Test result 1 from side-view .....	127
Figure J.3 – Geometry and measurement position of WPT system for RPA .....	128

Figure J.4 – Measured magnetic field strength.....	129
Figure J.5 – Measured and computed magnetic field strength .....	129
Figure J.6 – Measurement system for the magnetic near-field of WPT systems [83] .....	133
Figure J.7 – Schematic view and picture of the fabricated magnetic-field probes [83] .....	133
Figure J.8 – Schematic view (left) and picture (right) of WPT systems [83] .....	135
Figure J.9 – Exposure conditions for WPT coils [83] .....	135
Figure J.10 – Amplitude and phase distributions of magnetic fields measured near WPT systems without (w/o) and with (w/) ferrite tiles [83].....	136
Figure J.11 – Distribution of the internal electric field strength with adult male model for an input power of 7,7 kW [83].....	137
Figure J.12 – WPT system operating at 6,78 MHz.....	138
Figure J.13 – SAR distribution on a plane at 25 mm from the bottom of the phantom .....	138
Figure K.1 – Test side consideration drawing .....	141
Figure K.2 – Positioning of the phantom and the DUT WPT for determining the detection sensor triggering distance, an example of charging an electric vehicle with a WPT system .....	141
Table 1 – List of symbols used in the formulas of 5.2.4.2 and 5.2.4.3 .....	24
Table 2 – Dielectric properties of the tissue-equivalent medium liquid .....	35
Table 3 – Dielectric properties of the tissue-equivalent medium NaCl solution of 0,074 mol/L .....	35
Table 4 – Computational methods .....	39
Table 5 – Example of uncertainty evaluation of the the E-field and H-field exposure assessment using measurement methods .....	43
Table 6 – Example of uncertainty evaluation of computational methods.....	47
Table 7 – Example of uncertainty evaluation of the exposure assessment combining measurements and computational methods .....	51
Table B.1 – EM field generation setups for probe and sensor calibrations .....	58
Table B.2 – Main components of H-field and E-field generation setups for frequency response calibration.....	60
Table B.3 – Template for uncertainty in frequency response calibration.....	61
Table B.4 – Main components of H-field generation setup for dynamic range calibration.....	62
Table B.5 – Template for uncertainty in H-field dynamic range calibration .....	62
Table B.6 – Main components of E-field generation setup for frequency response calibration.....	64
Table B.7 – Template for uncertainty in E-field frequency response calibration.....	64
Table B.8 – Main components of E-field generation setup for dynamic range calibration.....	65
Table B.9 – Template for the uncertainty of the E-field dynamic range .....	66
Table B.10 – Template for uncertainty of the H-field gradient verification .....	68
Table B.11 – Uncertainty template for evaluation of average internal electric field produced by short dipole antenna via transmit antenna factor .....	72
Table E.1 – Measurement uncertainty of 10 g averaged SAR .....	87
Table H.1 – Interpolation and superposition of vector field components for loop currents $I$ and phase offsets $\xi$ .....	103

Table J.1 – Computed coupling factor $k_L$ .....	130
Table J.2 – Evaluation results using coupling factor $k_L$ .....	130
Table J.3 – Evaluation results using coupling factor $k_G$ .....	131
Table J.4 – Computational results of current density ( $J$ ), internal electric field ( $E$ ), and spatial peak 10 g average SAR ( $SAR_{10\text{ g}}$ ) .....	132

**iTeh Standards**  
**(<https://standards.iteh.ai>)**  
**Document Preview**

[IEC/IEEE 63184:2025](https://standards.iteh.ai/catalog/standards/iec/873be6fc-58ff-4764-a1c2-a1356c76fcfd/iec-ieee-63184-2025)

<https://standards.iteh.ai/catalog/standards/iec/873be6fc-58ff-4764-a1c2-a1356c76fcfd/iec-ieee-63184-2025>

# ASSESSMENT METHODS OF THE HUMAN EXPOSURE TO ELECTRIC AND MAGNETIC FIELDS FROM WIRELESS POWER TRANSFER SYSTEMS – MODELS, INSTRUMENTATION, MEASUREMENT AND COMPUTATIONAL METHODS AND PROCEDURES (FREQUENCY RANGE OF 3 kHz TO 30 MHz)

## FOREWORD

- 1) The International Electrotechnical Commission (IEC) is a worldwide organization for standardization comprising all national electrotechnical committees (IEC National Committees). The object of IEC is to promote international co-operation on all questions concerning standardization in the electrical and electronic fields. To this end and in addition to other activities, IEC publishes International Standards, Technical Specifications, Technical Reports, Publicly Available Specifications (PAS) and Guides (hereafter referred to as "IEC document(s)"). Their preparation is entrusted to technical committees; any IEC National Committee interested in the subject dealt with may participate in this preparatory work. International, governmental and non-governmental organizations liaising with the IEC also participate in this preparation.

IEEE Standards documents are developed within IEEE Societies and subcommittees of IEEE Standards Association (IEEE SA) Board of Governors. IEEE develops its standards through an accredited consensus development process, which brings together volunteers representing varied viewpoints and interests to achieve the final product. IEEE standards are documents developed by volunteers with scientific, academic, and industry-based expertise in technical working groups. Volunteers involved in technical working groups are not necessarily members of IEEE or IEEE SA and participate without compensation from IEEE. While IEEE administers the process and establishes rules to promote fairness in the consensus development process, IEEE does not independently evaluate, test, or verify the accuracy of any of the information or the soundness of any judgments contained in its standards.

IEC collaborates closely with IEEE in accordance with conditions determined by agreement between the two organizations. This Dual Logo International Standard was jointly developed by the IEC and IEEE under the terms of that agreement.

- 2) The formal decisions of IEC on technical matters express, as nearly as possible, an international consensus of opinion on the relevant subjects since each technical committee has representation from all interested IEC National Committees. The formal decisions of IEEE on technical matters, once consensus within IEEE Societies and Standards Coordinating Committees has been reached, is determined by a balanced ballot of materially interested parties who indicate interest in reviewing the proposed standard. Final approval of the IEEE standards document is given by the IEEE Standards Association (IEEE SA) Standards Board.

- 3) IEC/IEEE Publications have the form of recommendations for international use and are accepted by IEC National Committees/IEEE Societies in that sense. While all reasonable efforts are made to ensure that the technical content of IEC/IEEE Publications is accurate, IEC or IEEE cannot be held responsible for the way in which they are used or for any misinterpretation by any end user.

- 4) In order to promote international uniformity, IEC National Committees undertake to apply IEC Publications (including IEC/IEEE Publications) transparently to the maximum extent possible in their national and regional publications. Any divergence between any IEC/IEEE Publication and the corresponding national or regional publication shall be clearly indicated in the latter.

- 5) IEC and IEEE do not provide any attestation of conformity. Independent certification bodies provide conformity assessment services and, in some areas, access to IEC marks of conformity. IEC and IEEE are not responsible for any services carried out by independent certification bodies.

- 6) All users should ensure that they have the latest edition of this publication.

- 7) No liability shall attach to IEC or IEEE or their directors, employees, servants or agents including individual experts and members of technical committees and IEC National Committees, or volunteers of IEEE Societies and the Standards Coordinating Committees of the IEEE Standards Association (IEEE SA) Standards Board, for any personal injury, property damage or other damage of any nature whatsoever, whether direct or indirect, or for costs (including legal fees) and expenses arising out of the publication, use of, or reliance upon, this IEC/IEEE Publication or any other IEC or IEEE Publications.

- 8) Attention is drawn to the normative references cited in this publication. Use of the referenced publications is indispensable for the correct application of this publication.

- 9) Attention is drawn to the possibility that implementation of this IEC/IEEE Publication may require use of material covered by patent rights. By publication of this standard, no position is taken with respect to the existence or validity of any patent rights in connection therewith. IEC or IEEE shall not be held responsible for identifying Essential Patent Claims for which a license may be required, for conducting inquiries into the legal validity or scope of Patent Claims or determining whether any licensing terms or conditions provided in connection with submission of a Letter of Assurance, if any, or in any licensing agreements are reasonable or non-discriminatory. Users of this standard are expressly advised that determination of the validity of any patent rights, and the risk of infringement of such rights, is entirely their own responsibility.

IEC/IEEE 63184 was prepared by IEC technical committee 106: Methods for the assessment of electric, magnetic and electromagnetic fields associated with human exposure, in cooperation with International Committee on Electromagnetic Safety (ICES) of the IEEE Standards Association, under the IEC/IEEE Dual Logo Agreement between IEC and IEEE. It is an International Standard.

This document is published as an IEC/IEEE Dual Logo standard.

The text of this International Standard is based on the following IEC documents:

Draft	Report on voting
106/669/FDIS	106/685/RVD

Full information on the voting for its approval can be found in the report on voting indicated in the above table.

The language used for the development of this International Standard is English.

This document was drafted in accordance with the rules given in the ISO/IEC Directives, Part 2, available at [www.iec.ch/members\\_experts/refdocs](http://www.iec.ch/members_experts/refdocs). The main document types developed by IEC are described in greater detail at [www.iec.ch/publications/](http://www.iec.ch/publications/).

This first edition of IEC/IEEE 63184 cancels and replaces the first edition of IEC PAS 63184 published in 2021. This edition constitutes a technical revision.

This edition includes the following significant technical changes with respect to the previous edition:

- a) lower frequency bound changed from 1 kHz to 3 kHz;
- b) clarified contact currents as indirect effects in assessment procedures;
- c) in measurement methods applied the formulas of SAR and internal electric field;
- d) in computational assessment methods added specifications for averaging of current density and internal E-field;
- e) updated uncertainty of computational methods;
- f) introduced test reporting contents guidance.

The IEC Technical Committee and IEEE Technical Committee have decided that the contents of this document will remain unchanged until the stability date indicated on the IEC website under [webstore.iec.ch](http://webstore.iec.ch) in the data related to the specific document. At this date, the document will be

- reconfirmed,
- withdrawn, or
- revised.

## INTRODUCTION

The wireless power transmission systems described in the scope of this document require particularly developed procedures and protocols for the assessment of human exposure. Such systems are increasingly being implemented in a wide range of applications at different frequency ranges from consumer electronics (e.g. mobile phones, tablet PCs) to automotive (electric vehicles). Human exposure to electric and magnetic fields is limited to avoid established adverse health effects, including electrostimulation of nervous tissues and thermal effects, as well as contact currents. A published ITU-R report (ITU-R SM.2303-3 [1]<sup>1</sup>) on WPT systems specifies RF exposure assessment methodologies, yet no definitive assessment method was introduced. An exposure assessment method of WPT for EV charging systems was specified in IEC 61980-3:2022 [2]; however, there are currently no other detailed product standards related to WPT systems. Because WPT systems will continue to become ubiquitous in a multitude of applications in the future, IEC and IEEE established a joint working group to address WPT system assessment methods related to human exposures to electric, magnetic, and electromagnetic fields.

In this document, the basic methods to assess both direct and indirect effects of exposure to WPT systems, case studies, and relevant research are specified. These methods mainly focus on frequencies between 3 kHz and 30 MHz and consider both electrostimulation and thermal effects. Future editions will consider extended guidance for assessments of exposure from capacitive WPT systems.

iTeh Standards  
(<https://standards.iteh.ai>)  
Document Preview

[IEC/IEEE 63184:2025](https://standards.iteh.ai/catalog/standards/iec/873be6fc-58ff-4764-a1c2-a1356c76fcfd/iec-ieee-63184-2025)

<https://standards.iteh.ai/catalog/standards/iec/873be6fc-58ff-4764-a1c2-a1356c76fcfd/iec-ieee-63184-2025>

---

<sup>1</sup> Numbers in square brackets refer to the Bibliography.